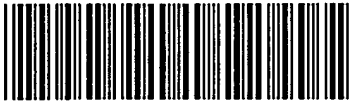


Search Notes

Application/Control No.

10/766,035

Examiner

Jeffrey D. Lane

Applicant(s)/Patent under
Reexamination

ANDO ET AL.

Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner
372	45.01	1/18/2006	JL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Semi-conductor laser with a luminous wavelength	1/18/2006	JL
Semiconductor film layer	1/19/2006	JL
Use of DFB lasers	1/19/2006	JL
Etching of top layers	1/19/2006	JL